Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/784,678	FUKAYA ET AL.
Examiner	**Art Unit**
Stephen J. Stein	1775

SEARCHED			
Class	Subclass	Date	Examiner
428	469	2/3/2006	SJS
428	702	2/3/2006	SJS
to date		07/06	pmc

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventor Search	2/3/2006	SJS
West Search (JPO/EPO/Derwent/USPAT) (PGPUBS)	2/2/2006	SJS